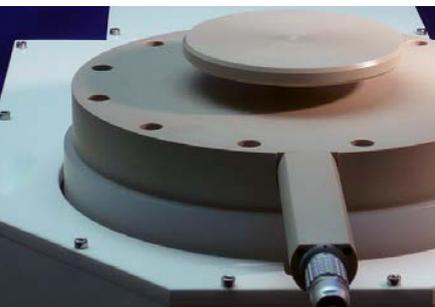
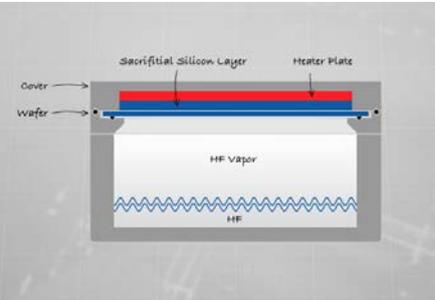


# HF VAPOR ETCHER HFVE SYSTEM

PRODUCT INFORMATION SHEET



Working principle of HF vapor etching



HFVE System with head stage

**HF Vapor Etching.** Hydrofluoric acid (HF) is an ideal etchant for all silicon oxide types used in micromachining, since it allows fast etch rates and is highly selective against silicon. A typical application for HF etching is the removal of sacrificial oxide layers in MEMS fabrication. However, as is typical for liquid-phase etchants, there is a high risk of the movable structure sticking to the substrate due to the effects of surface tension.

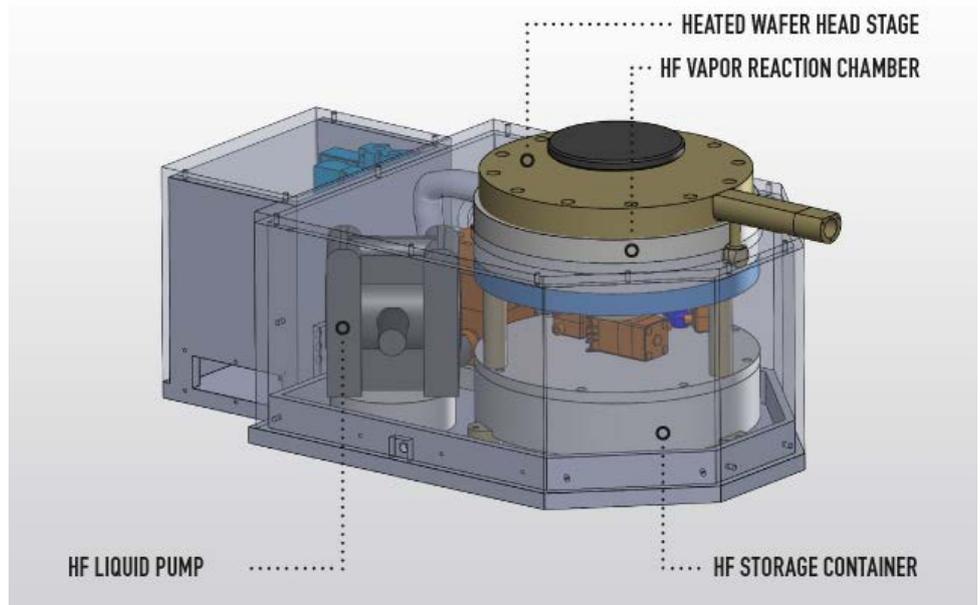
AMMT's HF Vapor Etcher solves this problem by working entirely in the vapor phase, which is a quasi dry process. The HF Vapor Etcher is perfectly adapted to surface micromachining, SOI-MEMS, dicing-free release, structure thinning, and many other applications.

The wafer is mounted onto the reaction cell with the etching side facing down. HF vapor is generated passively from a small liquid reservoir at the bottom of the reaction cell. The HF vapor reacts with the  $\text{SiO}_2$  on the wafer surface to form volatile  $\text{SiF}_4$ , which desorbs readily from the surface. The reaction also requires small amounts of water to be present on the surface. In order to ensure a microscopic water film on the surface without producing droplets which could cause sticking, the wafer is gently heated from the backside by an HF-resistant precision heater plate. An excellent etching homogeneity is achieved by our special heater design, which minimizes temperature gradients over the wafer that could affect the etch rate.

**HFVE System & process cycle.** The HFVE system consists of a reaction cell, a heated wafer holder, and an HF handling system with an HF storage container, in addition to an electronic control unit. The wafer temperature and process duration are set at the control unit.

First the wafer has to be mounted in the wafer holder and placed onto the reaction cell. Once the wafer's temperature has reached the set point, the system automatically pumps HF from the storage container into the reaction cell. After the preset process duration is over, the HF is automatically drained into the storage container and the reaction cell is flushed out with nitrogen.

The wafer can now be removed safely, because the reaction cell is free of HF vapor. The HF can be used for multiple etching cycles.



HF VAPOR ETCHER (HFVE SYSTEM)

## AMMT

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## TECHNICAL SPECIFICATIONS

Product code	HFVE System 4	HFVE System 6
Wafer size	4" (100mm) or smaller	6" (150mm) or smaller
External dimensions		
Etcher (width x width x height)	657 x 340 x 288 mm <sup>3</sup>	
Base plate (width x width)	580 x 340 mm <sup>2</sup>	
Control unit (width x height x depth)	200 x 150 x 200 mm <sup>3</sup>	
Materials		
Heater housing and wafer holder	PEEK	
Heater	Fully sealed aluminum heater with silicon cover	
HF reaction cell	PP	
Safety receptacle	PP welded	
O-rings	Viton	
Etchant volume	350 ml	
Etchant compatibility	HF 50% or less and mixtures of HF and organic solvents	
Temperature control		
Heater type	Resistive heater, fully HF protected	
Heater power	60 W max.	
Heater power supply	110 - 230 V, 60 VA, 48-63 Hz	
Temperature range	Room temperature to 60°C	
Temperature sensors	Pt100 (one embedded heater, one in the main unit)	
Temperature controller	Electronic PID controller with differential temperature measurement and PWM output	
User parameters	Process duration, Wafer temperature Nitrogen preflush time, Nitrogen endflush time	
Mode of operation	absolute temperature / relative temperature in respect to room temperature	
Required supplies		
Nitrogen	[6 .. 7 bar]	
Vapor exhaust	acid proof, flow min. 30m/min	

## OPTIONS

For dicing free release applications a HF proof mesh is available.  
For small chips an electrostatic chuck is available.



HFVE electrostatic chuck



HFVE System electronic control unit

**NOTE:** Hydrofluoric acid (HF) is an extremely dangerous substance to work with. Special care has to be taken when installing, maintaining, and operating this system. In particular, a secure mount for the device and an appropriate vapor extraction **must be secured**. AMMT can provide information about the installation and operation of the HFVE system, but will not assume any responsibility for harm or damage caused by using this product.